Low Power, Standard Frequency Oscillator



# **Features**

- 52 standard frequencies between 3.57 MHz and 77.76 MHz
- 100% pin-to-pin drop-in replacement to quartz-based XO
- Excellent total frequency stability as low as ±20 ppm
- Operating temperature from -40°C to 85°C. For 125°C and/or -55°C options, refer to SiT1618, SiT8918, SiT8920
- Low power consumption of 3.5 mA typical at 1.8 V
- Qualify just one device with 1.62 V to 3.63 V continuous supply voltage
- Standby mode for longer battery life
- Fast startup time of 5 ms
- LVCMOS/HCMOS compatible output
- Industry-standard packages: 2.0 x 1.6, 2.5 x 2.0, 3.2 x 2.5, 5.0 x 3.2, 7.0 x 5.0 mm x mm
- Instant samples with Time Machine II and Field Programmable Oscillators
- RoHS and REACH compliant, Pb-free, Halogen-free and Antimony-free
- For AEC-Q100 oscillators, refer to SiT8924 and SiT8925

# **Electrical Characteristics**

All Min and Max limits are specified over temperature and rated operating voltage with 15 pF output load unless otherwise stated. Typical values are at 25°C and nominal supply voltage.





# **Applications**

- Ideal for DSC, DVC, DVR, IP CAM, Tablets, e-Books, SSD, GPON, EPON, etc
- Ideal for high-speed serial protocols such as: USB, SATA, SAS, Firewire, 100M/1G/10G Ethernet, etc.



# **Table 1. Electrical Characteristics (continued)**



# **Table 2. Pin Description**



# **Notes:**

- 1. In OE or ST mode, a pull-up resistor of 10 kΩ or less is recommended if pin 1 is not externally driven. If pin 1 needs to be left floating, use the NC option.
- 2. A capacitor of value 0.1 µF or higher between Vdd and GND is required.

 $\sqrt{3}$  OUT

VDD

 $\sqrt{4}$ 

**Si**Time

# **Table 3. Absolute Maximum Limits**

Attempted operation outside the absolute maximum ratings may cause permanent damage to the part. Actual performance of the IC is only guaranteed within the operational specifications, not at absolute maximum ratings.



**Note:**

3. Exceeding this temperature for extended period of time may damage the device.

# **Table 4. Thermal Consideration[4]**



**Note:**

4. Refer to JESD51 for  $\theta$ JA and  $\theta$ JC definitions, and reference layout used to determine the  $\theta$ JA and  $\theta$ JC values in the above table.

#### **Table 5. Maximum Operating JunctionTemperature[5]**



**Note:**

5. Datasheet specifications are not guaranteed if junction temperature exceeds the maximum operating junction temperature.

#### **Table 6. Environmental Compliance**







# **Test Circuit and Waveform[6]**





#### **Note:**

6. Duty Cycle is computed as Duty Cycle =TH/Period.

# **Timing Diagrams**



# **Figure 4. Startup Timing (OE/ ST ̅ ̅ Mode)**



#### **Figure 6. OE Enable Timing (OE Mode Only)**

#### **Note:**

7. SiT1602 has "no runt" pulses and "no glitch" output during startup or resume.



**Figure 3. Waveform**



# **Figure 5. Standby Resume Timing ( ST ̅ ̅ ModeOnly)**



# **Figure 7. OE Disable Timing (OE ModeOnly)**



# **Performance Plots[8]**





**Figure 10. RMS Period Jitter vs Frequency Figure 11. Duty Cycle vs Frequency**

![](_page_4_Figure_7.jpeg)

**Figure 12. 20%-80% Rise Timevs Temperature Figure 13. 20%-80% Fall Time vsTemperature**

![](_page_4_Figure_9.jpeg)

**Figure 8. Idd vs Frequency Figure 9. Frequency vsTemperature**

![](_page_4_Figure_11.jpeg)

![](_page_4_Figure_13.jpeg)

![](_page_5_Picture_0.jpeg)

# **Performance Plots[8] (continued)**

![](_page_5_Figure_3.jpeg)

**Figure 14. RMS Integrated Phase JitterRandom (12 kHz to 20 MHz) vs Frequency[9]**

![](_page_5_Figure_5.jpeg)

**Figure 15. RMS Integrated Phase Jitter Random (900 kHz to 20 MHz) vs Frequency[9]**

**Notes:**

8. All plots are measured with 15 pF load at room temperature, unless otherwise stated.

9. Phase noise plots are measured with Agilent E5052B signal source analyzer. Integration range is up to 5 MHz for carrier frequencies below 40 MHz.

# **Programmable Drive Strength**

The SiT1602 includes a programmable drive strength feature to provide a simple, flexible tool to optimize the clock rise/fall time for specific applications. Benefits from the programmable drive strength feature are:

- Improves system radiated electromagnetic interference (EMI) by slowing down the clock rise/fall time
- Improves the downstream clock receiver's (RX) jitter by decreasing (speeding up) the clock rise/fall time.
- Ability to drive large capacitive loads while maintaining full swing with sharp edge rates.

For more detailed information about rise/fall time control and drive strength selection, see the SiTime Application Notes section.

# **EMI Reduction by Slowing Rise/Fall Time**

Figure 16 shows the harmonic power reduction as the rise/fall times are increased (slowed down). The rise/fall times are expressed as a ratio of the clock period. For the ratio of 0.05, the signal is very close to a square wave. For the ratio of 0.45, the rise/fall times are very close to neartriangular waveform. These results, for example, show that the 11<sup>th</sup> clock harmonic can be reduced by 35 dB if the rise/fall edge is increased from 5% of the period to 45% of the period.

![](_page_6_Figure_10.jpeg)

**Figure 16. Harmonic EMI reduction as a Function of Slower Rise/Fall Time**

# **Jitter Reduction with Faster Rise/Fall Time**

Power supply noise can be a source of jitter for the downstream chipset. One way to reduce this jitter is to speed up the rise/fall time of the input clock. Some chipsets may also require faster rise/fall time in order to reduce their sensitivity to this type of jitter. Refer to the Rise/Fall Time Tables (Table 7 to Table 11) to determine the proper drive strength.

# **High Output Load Capability**

The rise/fall time of the input clock varies as a function of the actual capacitive load the clock drives. At any given drive strength, the rise/fall time becomes slower as the output load increases. As an example, for a 3.3 V SiT1602 device with default drive strength setting, the typical rise/fall time is 1 ns for 15 pF output load. The typical rise/fall time slows down to 2.6 ns when the output load increases to 45 pF. One can choose to speed up the rise/fall time to 1.83 ns by then increasing the drive strength setting on the SiT1602.

The SiT1602 can support up to 60 pF or higher in maximum capacitive loads with drive strength settings. Refer to the Rise/Fall Time Tables (Table 7 to 11) to determine the proper drive strength for the desired combination of output load vs. rise/fall time.

# **SiT1602 Drive Strength Selection**

Tables 7 through 11 define the rise/fall time for a given capacitive load and supply voltage.

- **1.** Select the table that matches the SiT1602 nominal supply voltage (1.8 V, 2.5 V, 2.8 V, 3.0 V, 3.3 V).
- **2.** Select the capacitive load column that matches the application requirement (5 pF to 60 pF)
- **3.** Under the capacitive load column, select the desired rise/fall times.
- **4.** The left-most column represents the part number code for the corresponding drive strength.
- **5.** Add the drive strength code to the part number for ordering purposes.

# **Calculating Maximum Frequency**

Any given rise/fall time in Table 7 through 11 dictates the maximum frequency under which the oscillator can operate with guaranteed full output swing over the entire operating temperature range. This max frequency can be calculated as the following:

$$
\text{Max Frequency} = \frac{1}{5 \times \text{Trf}_20/80}
$$

where Trf\_20/80 is the typical value for 20%-80% rise/fall time.

# **Example 1**

Calculate f<sub>MAX</sub> for the following condition:

- $Vdd = 1.8 V (Table 7)$
- Capacitive Load: 30 pF
- Desired Tr/f time = 3 ns (rise/fall time part number  $code = E)$
- $f_{MAX} = 66.66660$

Part number for the above example:

# SiT1602BI**E**12-18E-66.666660

Drive strength code is inserted here. Default setting is "-"

![](_page_7_Picture_1.jpeg)

# **Rise/Fall Time (20% to 80%) vs CLOAD Tables**

**Table 7. Vdd = 1.8 V (Vdd\_1.8) Rise/Fall Times for Specific CLOAD** 

![](_page_7_Picture_774.jpeg)

# **Table 9. Vdd = 2.8 V (Vdd\_2.8) Rise/Fall Times for Specific CLOAD**

![](_page_7_Picture_775.jpeg)

# **Table 11. Vdd = 3.3 V (Vdd\_3.3) Rise/Fall Times for Specific CLOAD**

![](_page_7_Picture_776.jpeg)

# **Table 8. Vdd = 2.5 V (Vdd\_2.5) Rise/Fall Times for Specific CLOAD**

![](_page_7_Picture_777.jpeg)

# **Table 10. Vdd = 3.0 V (Vdd\_3.0) Rise/Fall Times for Specific CLOAD**

![](_page_7_Picture_778.jpeg)

# **Pin 1 Configuration Options (OE, ST ̅ ̅, or NC)**

Pin 1 of the SiT1602 can be factory-programmed to support three modes: Output Enable (OE), standby  $(ST)$  or No Connect (NC). These modes can also be programmed with the Time Machine using field programmable devices.

# **Output Enable (OE) Mode**

In the OE mode, applying logic Low to the OE pin only disables the output driver and puts it in Hi-Z mode. The core of the device continues to operate normally. Power consumption is reduced due to the inactivity of the output. When the OE pin is pulled High, the output is typically enabled in  $\leq$ 1 µs.

# Standby (ST) Mode

In the  $\overline{ST}$  mode, a device enters into the standby mode when Pin 1 pulled Low. All internal circuits of the device are turned off. The current is reduced to a standby current, typically in the range of a few  $\mu$ A. When  $\overline{ST}$  is pulled High, the device goes through the "resume" process, which can take up to 5 ms.

# **No Connect (NC) Mode**

In the NC mode, the device always operates in its normal mode and outputs the specified frequency regardless of the logic level on pin 1.

Table 12 below summarizes the key relevant parameters in the operation of the device in  $OE$ ,  $ST$ , or NC mode.

![](_page_8_Picture_520.jpeg)

# **Table 12. OE vs.**  $\overline{ST}$  **vs. NC**

# **Output on Startup and Resume**

The SiT1602 comes with gated output. Its clock output is accurate to the rated frequency stability within the first pulse from initial device startup or resume from the standby mode.

In addition, the SiT1602 features "no runt" pulses and "no glitch" output during startup or resume as shown in the waveform captures in Figure 17 and Figure 18.

![](_page_8_Figure_16.jpeg)

**Figure 17. Startup Waveform vs. Vdd**

![](_page_8_Figure_18.jpeg)

**Figure 18. Startup Waveform vs. Vdd (Zoomed-in View of Figure 17)**

# **Instant Samples with Time Machine and Field Programmable Oscillators**

SiTime supports a field programmable version of the SiT1602 low power oscillator for fast prototyping and real time customization of features. The field programmable devices (FP devices) are available for all five standard SiT1602 package sizes and can be configured to one's exact specification using the Time Machine II, an USB powered MEMS oscillator programmer.

#### **Customizable Features of the SiT1602 FP Devices Include**

- 52 standard frequencies between 3.75 MHz and 77.76 MHz (Refer to the frequency list on page 12)
- Three frequency stability options, ±20 ppm, ±25 ppm,  $±50$  ppm
- Two operating temperatures, -20 to 70°C or -40 to 85°C
- Six supply voltage options,  $1.8$  V,  $2.5$  V,  $2.8$  V,  $3.0$  V, 3.3 V, 2.25 to 3.65 V, and 1.62 to 3.63 V continuous
- Output drive strength
- OE, ST or NC mode

For more information regarding SiTime's field programmable solutions, see Time Machine II and Field Programmable Oscillators.

SiT1602 is typically factory-programmed per customer ordering codes for volume delivery.

![](_page_9_Picture_1.jpeg)

# **Dimensions and Patterns**

![](_page_9_Figure_3.jpeg)

![](_page_10_Picture_1.jpeg)

# **Dimensions and Patterns (continued)**

![](_page_10_Figure_3.jpeg)

![](_page_11_Picture_1.jpeg)

# **Dimensions and Patterns (continued)**

![](_page_11_Figure_3.jpeg)

#### **Notes:**

- 10. Top marking: Y denotes manufacturing origin and XXXX denotes manufacturing lot number. The value of "Y" will depend on the assembly location of the device.
- 11. A capacitor of value 0.1 µF or higher between Vdd and GND is required.

# **Ordering Information**

The Part No. Guide is for reference only.

To customize and build an exact part number, use the SiTime Part Number Generator.

![](_page_12_Figure_5.jpeg)

# **Table 13. List of Supported Frequencies**

![](_page_12_Picture_444.jpeg)

**Table 14. Ordering Codes for Supported Tape & Reel Packing Method**

![](_page_12_Picture_445.jpeg)

![](_page_13_Picture_1.jpeg)

### **Table 15. Additional Information**

![](_page_13_Picture_736.jpeg)

### **Table 16. Revision History**

![](_page_13_Picture_737.jpeg)

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![](_page_14_Picture_1.jpeg)

# **Supplemental Information**

The Supplemental Information section is not part of the datasheet and is for informational purposes only.

# **Best Reliability**

Silicon is inherently more reliable than quartz. Unlike quartz suppliers, SiTime has in-house MEMS and analog CMOS expertise, which allows SiTime to develop the most reliable products. Figure 1 shows a comparison with quartz technology.

### **Why is SiTime MEMS Best in Class:**

- SiTime's MEMS resonators are vacuum sealed using an advanced EpiSeal™ process, which eliminates foreign particles and improves long term aging and reliability
- World-class MEMS and CMOS design expertise

![](_page_15_Figure_7.jpeg)

**Figure 1. Reliability Comparison[1]**

# **Best Aging**

Unlike quartz, MEMS oscillators have excellent long term aging performance which is why every new SiTime product specifies 10-year aging. A comparison is shown in Figure 2.

# **Why is SiTime Best in Class:**

- SiTime's MEMS resonators are vacuum sealed using an advanced EpiSeal™ process, which eliminates foreign particles and improves long term aging and reliability
- Inherently better immunity of electrostatically driven MEMS resonator

![](_page_15_Figure_14.jpeg)

**Figure 2. Aging Comparison[2]**

# **Best Electro Magnetic Susceptibility (EMS)**

SiTime's oscillators in plastic packages are up to 54 times more immune to external electromagnetic fields than quartz oscillators as shown in Figure 3.

# **Why is SiTime Best in Class:**

- Internal differential architecture for best common mode noise rejection
- Electrostatically driven MEMS resonator is more immune to EMS

![](_page_15_Figure_21.jpeg)

**Figure 3. Electro Magnetic Susceptibility (EMS)[3]**

# **Best Power Supply Noise Rejection**

SiTime's MEMS oscillators are more resilient against noise on the power supply. A comparison is shown in Figure 4.

# **Why is SiTime Best in Class:**

- On-chip regulators and internal differential architecture for common mode noise rejection
- MEMS resonator is paired with advanced analog CMOS IC

![](_page_15_Figure_28.jpeg)

**Figure 4. Power Supply Noise Rejection[4]**

![](_page_16_Picture_1.jpeg)

# **Best Vibration Robustness**

High-vibration environments are all around us. All electronics, from handheld devices to enterprise servers and storage systems are subject to vibration. Figure 5 shows a comparison of vibration robustness.

#### **Why is SiTime Best in Class:**

- The moving mass of SiTime's MEMS resonators is up to 3000 times smaller than quartz
- Center-anchored MEMS resonator is the most robust design

![](_page_16_Figure_7.jpeg)

**Figure 5. Vibration Robustness[5]**

# **Best Shock Robustness**

SiTime's oscillators can withstand at least 50,000 *g* shock. They all maintain their electrical performance in operation during shock events. A comparison with quartz devices is shown in Figure 6.

#### **Why is SiTime Best in Class:**

- The moving mass of SiTime's MEMS resonators is up to 3000 times smaller than quartz
- Center-anchored MEMS resonator is the most robust design

![](_page_16_Figure_14.jpeg)

**Figure 6. Shock Robustness[6]**

#### **Figure labels:**

- $\blacksquare$  TXC = TXC
- Epson = EPSN
- Connor Winfield = CW
- Kyocera = KYCA
- SiLabs = SLAB
- SiTime = EpiSeal MEMS

![](_page_17_Picture_1.jpeg)

#### **Notes:**

- 1. Data source: Reliability documents of named companies.
- 2. Data source: SiTime and quartz oscillator devices datasheets. 3. Test conditions for Electro Magnetic Susceptibility (EMS):
- 
- According to IEC EN61000-4.3 (Electromagnetic compatibility standard)
- Field strength: 3V/m
- Radiated signal modulation: AM 1 kHz at 80% depth
- Carrier frequency scan: 80 MHz 1 GHz in 1% steps
- **•** Antenna polarization: Vertical
- DUT position: Center aligned to antenna

#### **Devices used in this test:**

![](_page_17_Picture_271.jpeg)

# 4. 50 mV pk-pk Sinusoidal voltage.

# **Devices used in this test:**

![](_page_17_Picture_272.jpeg)

5. Devices used in this test:

same as EMS test stated in Note 3.

- 6. Test conditions for shock test:
	- MIL-STD-883F Method 2002
	- Condition A: half sine wave shock pulse, 500-g, 1ms
	- Continuous frequency measurement in 100 μs gate time for 10 seconds

**Devices used in this test:**

same as EMS test stated in Note 3.

7. Additional data, including setup and detailed results, is available upon request to qualified customer. Please contact productsupport@sitime.com.

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